<0.5 Ω CMOS, 1.65 V to 3.6 V, Quad SPST Switches

ADG811/ADG812/ADG813

FEATURES

0.5 Ω typical on resistance
0.8 Ω maximum on resistance at 125°C
1.65 V to 3.6 V operation
Automotive temperature range: –40°C to +125°C
High current carrying capability: 300 mA continuous
Rail-to-rail switching operation
Fast switching times: <25 ns
Typical power consumption <0.1 μW

APPLICATIONS

Cellular phones
MP3 players
Power routing
Battery-powered systems
PCMCIA cards
Modems
Audio and video signal routing
Communications systems

FUNCTIONAL BLOCK DIAGRAMS

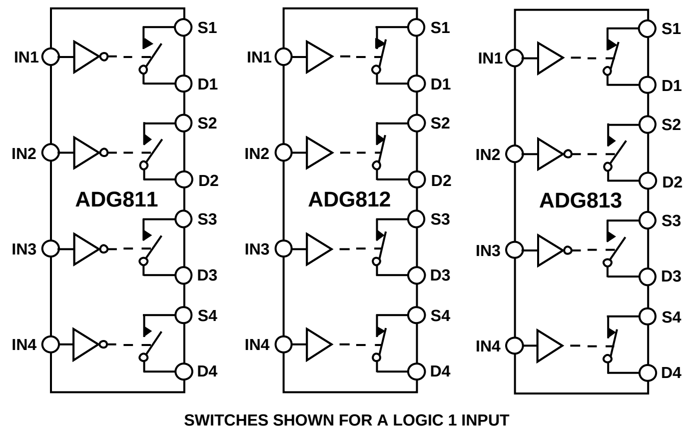

Figure 1.

GENERAL DESCRIPTION

The ADG811/ADG812/ADG813 are low voltage CMOS devices containing four independently selectable switches. These switches offer ultralow on resistance of less than 0.8 Ω over the full temperature range. The digital inputs can handle 1.8 V logic with a 2.7 V to 3.6 V supply.

These devices contain four independent single-pole/single-throw (SPST) switches. The ADG811 and ADG812 differ only in that the digital control logic is inverted. The ADG811 switches are turned on with a logic low on the appropriate control input, while a logic high is required to turn on the switches of the ADG812. The ADG813 contains two switches whose digital control logic is similar to the ADG811, while the logic is inverted on the other two switches.

Each switch conducts equally well in both directions when on and has an input signal range that extends to the supplies. The ADG813 exhibits break-before-make switching action.

The ADG811/ADG812/ADG813 are fully specified for 3.3 V, 2.5 V, and 1.8 V supply operation. The ADG811 is available in a 16-lead TSSOP package and a 16-lead LFCSP package, and the ADG812/ADG813 are available in a 16-lead TSSOP package.

PRODUCT HIGHLIGHTS

1. <0.8 Ω over full temperature range of –40°C to +125°C.
2. Single 1.65 V to 3.6 V operation.
3. Operational with 1.8 V CMOS logic.
4. High current handling capability (300 mA continuous current at 3.3 V).
5. Low THD + N (0.02% typical).
6. Small 3 mm × 3 mm LFCSP package and 16-lead TSSOP package.

Rev. B

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REVISION HISTORY

11/09—Rev. A to Rev. B

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5/04—Rev. 0 to Rev. A

Updated Format ... Universal
Updated Package Choices ... Universal

11/03—Revision 0: Initial Version

SPECIFICATIONS

V_{DD} = 2.7 V to 3.6 V, GND = 0 V, unless otherwise noted. Temperature range for the Y version is −40°C to +125°C.

Table 1.

Parameter	+25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			0 V to V_{DD}	V	
On Resistance, R_{ON}	0.5			Ω typ	V_{DD} = 2.7 V, V_S = 0 V to V_{DD}, I_S = 10 mA; see Figure 19
	0.65	0.75	0.8	Ω max	
On Resistance Match Between Channels, ΔR_{ON}	0.04			Ω typ	V_{DD} = 2.7 V, V_S = 0.5 V, I_S = 10 mA
		0.075	0.08	Ω max	
On Resistance Flatness, $R_{FLAT (ON)}$	0.1			Ω typ	V_{DD} = 2.7 V, V_S = 0 V to V_{DD}, I_S = 10 mA
		0.15	0.16	Ω max	
LEAKAGE CURRENTS					V_{DD} = 3.6 V
Source Off Leakage, I_S (Off)	±0.2			nA typ	V_S = 0.6 V/3.3 V, V_D = 3.3 V/0.6 V; see Figure 20
	±1	±8	±80	nA max	
Drain Off Leakage, I_D (Off)	±0.2			nA typ	V_S = 0.6 V/3.3 V, V_D = 3.3 V/0.6 V; see Figure 20
	±1	±8	±80	nA max	
Channel On Leakage, I_D, I_S (On)	±0.2			nA typ	V_S = V_D = 0.6 V or 3.3 V; see Figure 21
	±1	±15	±90	nA max	
DIGITAL INPUTS					
Input High Voltage, V_{INH}			2	V min	
Input Low Voltage, V_{INL}			0.8	V max	
Input Current, I_{INL} or I_{INH}	0.005			μA typ	V_{IN} = V_{INL} or V_{INH}
			±0.1	μA max	
C_{IN}, Digital Input Capacitance	6			pF typ	
DYNAMIC CHARACTERISTICS[1]					
t_{ON}	21			ns typ	R_L = 50 Ω, C_L = 35 pF
	25	26	28	ns max	V_S = 1.5 V/0 V; see Figure 22
t_{OFF}	4			ns typ	R_L = 50 Ω, C_L = 35 pF
	5	6	7	ns max	V_S = 1.5 V; see Figure 22
Break-Before-Make Time Delay, t_{BBM} (ADG813 Only)	17			ns typ	R_L = 50 Ω, C_L = 35 pF
			5	ns min	V_{S1} = V_{S2} = 1.5 V; see Figure 23
Charge Injection	30			pC typ	V_S = 1.5 V, R_S = 0 Ω, C_L = 1 nF; see Figure 24
Off Isolation	−67			dB typ	R_L = 50 Ω, C_L = 5 pF, f = 100 kHz; see Figure 25
Channel-to-Channel Crosstalk	−90			dB typ	R_L = 50 Ω, C_L = 5 pF, f = 100 kHz; see Figure 27
Total Harmonic Distortion (THD + N)	0.02			%	R_L = 32 Ω, f = 20 Hz to 20 kHz, V_S = 2 V p-p
Insertion Loss	−0.05			dB typ	R_L = 50 Ω, C_L = 5 pF, f = 100 kHz
−3 dB Bandwidth	90			MHz typ	R_L = 50 Ω, C_L = 5 pF; see Figure 26
C_S (Off)	30			pF typ	
C_D (Off)	35			pF typ	
C_D, C_S (On)	60			pF typ	
POWER REQUIREMENTS					V_{DD} = 3.6 V
I_{DD}	0.003			μA typ	Digital inputs = 0 V or 3.6 V
		1.0	4	μA max	

[1] Guaranteed by design, but not subject to production test.

V_{DD} = 2.5 V ± 0.2 V, GND = 0 V, unless otherwise noted. Temperature range for the Y version is −40°C to +125°C.

Table 2.

Parameter	+25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			0 V to V_{DD}	V	
On Resistance, R_{ON}	0.65			Ω typ	V_{DD} = 2.3 V, V_S = 0 V to V_{DD}, I_S = 10 mA; see Figure 19
	0.72	0.8	0.88	Ω max	
On Resistance Match Between Channels, ΔR_{ON}	0.04			Ω typ	V_{DD} = 2.3 V, V_S = 0.55 V, I_S = 10 mA
		0.08	0.085	Ω max	
On Resistance Flatness, $R_{FLAT (ON)}$	0.16			Ω typ	V_{DD} = 2.3 V, V_S = 0 V to V_{DD}, I_S = 10 mA
		0.23	0.24	Ω max	
LEAKAGE CURRENTS					V_{DD} = 2.7 V
Source Off Leakage, I_S (Off)	±0.2			nA typ	V_S = 0.6 V/2.4 V, V_D = 2.4 V/0.6 V; see Figure 20
	±1	±6	±35	nA max	
Drain Off Leakage, I_D (Off)	±0.2			nA typ	V_S = 0.6 V/2.4 V, V_D = 2.4 V/0.6 V; see Figure 20
	±1	±6	±35	nA max	
Channel On Leakage, I_D, I_S (On)	±0.2			nA typ	V_S = V_D = 0.6 V or 2.4 V; see Figure 21
	±1	±11	±70	nA max	
DIGITAL INPUTS					
Input High Voltage, V_{INH}			1.7	V min	
Input Low Voltage, V_{INL}			0.7	V max	
Input Current, I_{INL} or I_{INH}	0.005			μA typ	V_{IN} = V_{INL} or V_{INH}
			±0.1	μA max	
C_{IN}, Digital Input Capacitance	6			pF typ	
DYNAMIC CHARACTERISTICS[1]					
t_{ON}	22			ns typ	R_L = 50 Ω, C_L = 35 pF
	27	29	30	ns max	V_S = 1.5 V/ 0 V; see Figure 22
t_{OFF}	4			ns typ	R_L = 50 Ω, C_L = 35 pF
	6	7	8	ns max	V_S = 1.5 V; see Figure 22
Break-Before-Make Time Delay, t_{BBM} (ADG813 Only)	18			ns typ	R_L = 50 Ω, C_L = 35 pF
			5	ns min	V_{S1} = V_{S2} = 1.5 V; see Figure 23
Charge Injection	25			pC typ	V_S = 1.25 V, R_S = 0 Ω, C_L = 1 nF; see Figure 24
Off Isolation	−67			dB typ	R_L = 50 Ω, C_L = 5 pF, f = 100 kHz; see Figure 25
Channel-to-Channel Crosstalk	−90			dB typ	R_L = 50 Ω, C_L = 5 pF, f = 100 kHz; see Figure 27
Total Harmonic Distortion (THD + N)	0.022			%	R_L = 32 Ω, f = 20 Hz to 20 kHz, V_S = 1.5 V p-p
Insertion Loss	−0.06			dB typ	R_L = 50 Ω, C_L = 5 pF, f = 100 kHz
−3 dB Bandwidth	90			MHz typ	R_L = 50 Ω, C_L = 5 pF; see Figure 26
C_S (Off)	32			pF typ	
C_D (Off)	37			pF typ	
C_D, C_S (On)	60			pF typ	
POWER REQUIREMENTS					V_{DD} = 2.7 V
I_{DD}	0.003			μA typ	Digital inputs = 0 V or 2.7 V
		1.0	4	μA max	

[1] Guaranteed by design, but not subject to production test.

V_{DD} = 1.65 V to 1.95 V, GND = 0 V, unless otherwise noted. Temperature range for the Y version is −40°C to +125°C.

Table 3.

Parameter	+25°C	−40°C to +85°C	−40°C to +125°C	Unit	Test Conditions/Comments
ANALOG SWITCH					
Analog Signal Range			0 V to V_{DD}	V	
On Resistance, R_{ON}	1			Ω typ	V_{DD} = 1.8 V, V_S = 0 V to V_{DD}, I_S = 10 mA; see Figure 19
	1.4	2.2	2.2	Ω max	
	2.5	4	4	Ω max	V_{DD} = 1.65 V, V_S = 0 V to V_{DD}, I_S = 10 mA
On Resistance Match Between Channels, ΔR_{ON}	0.1			Ω typ	V_{DD} = 1.65 V, V_S = 0.7 V, I_S = 10 mA
LEAKAGE CURRENTS					V_{DD} = 1.95 V
Source Off Leakage I_S (Off)	±0.2			nA typ	V_S = 0.6 V/1.65 V, V_D = 1.65 V/0.6 V; see Figure 20
	±1	±5	±30	nA max	
Drain Off Leakage I_D (Off)	±0.2			nA typ	V_S = 0.6 V/1.65 V, V_D = 1.65 V/0.6 V; see Figure 20
	±1	±5	±30	nA max	
Channel On Leakage I_D, I_S (On)	±0.2			nA typ	V_S = V_D = 0.6 V or 1.65 V; see Figure 21
	±1	±9	±60	nA max	
DIGITAL INPUTS					
Input High Voltage, V_{INH}			$0.65V_{DD}$	V min	
Input Low Voltage, V_{INL}			$0.35V_{DD}$	V max	
Input Current, I_{INL} or I_{INH}	0.005			μA typ	V_{IN} = V_{INL} or V_{INH}
			±0.1	μA max	
CIN, Digital Input Capacitance	6			pF typ	
DYNAMIC CHARACTERISTICS[1]					
t_{ON}	27			ns typ	R_L = 50 Ω, C_L = 35 pF
	35	36	37	ns max	V_S = 1.5 V/ 0 V; see Figure 22
t_{OFF}	6			ns typ	R_L = 50 Ω, C_L = 35 pF
	8	9	10	ns max	V_S = 1.5 V; see Figure 22
Break-Before-Make Time Delay, t_{BBM} (ADG813 Only)	20			ns typ	R_L = 50 Ω, C_L = 35 pF
			5	ns min	V_{S1} = V_{S2} = 1 V; see Figure 23
Charge Injection	15			pC typ	V_S = 1 V, R_S = 0 Ω, C_L = 1 nF; see Figure 24
Off Isolation	−67			dB typ	R_L = 50 Ω, C_L = 5 pF, f = 100 kHz; Figure 25
Channel-to-Channel Crosstalk	−90			dB typ	R_L = 50 Ω, C_L = 5 pF, f = 100 kHz; see Figure 27
Total Harmonic Distortion (THD + N)	0.14			%	R_L = 32 Ω, f = 20 Hz to 20 kHz, V_S = 1.2 V p-p
Insertion Loss	−0.08			dB typ	R_L = 50 Ω, C_L = 5 pF, f = 100 kHz
−3 dB Bandwidth	90			MHz typ	R_L = 50 Ω, C_L = 5 pF; see Figure 26
C_S (Off)	32			pF typ	
C_D (Off)	38			pF typ	
C_D, C_S (On)	60			pF typ	
POWER REQUIREMENTS					V_{DD} = 1.95 V
I_{DD}	0.003			μA typ	Digital inputs = 0 V or 1.95 V
		1.0	4	μA max	

[1] Guaranteed by design, but not subject to production test.

ABSOLUTE MAXIMUM RATINGS

T_A = 25°C, unless otherwise noted.

Table 4.

Parameter	Rating
V_{DD} to GND	−0.3 V to +4.6 V
Analog Inputs[1]	−0.3 V to V_{DD} + 0.3 V
Digital Inputs[1]	GND − 0.3 V to 4.6 V or 10 mA, whichever occurs first
Peak Current, S or D	(Pulsed at 1 ms, 10% duty-cycle maximum)
3.3 V Operation	500 mA
2.5 V Operation	460 mA
1.8 V Operation	420 mA
Continuous Current, S or D	
3.3 V Operation	300 mA
2.5 V Operation	275 mA
1.8 V Operation	250 mA
Operating Temperature Range, Automotive (Y Version)	−40°C to +125°C
Storage Temperature Range	−65°C to +150°C
Junction Temperature	150°C
TSSOP Package	
θ_{JA} Thermal Impedance	150°C/W
θ_{JC} Thermal Impedance	27°C/W
LFCSP Package	
θ_{JA} Thermal Impedance	70°C/W
IR Reflow, Peak Temperature <20 sec	235°C

[1] Overvoltages at IN, S, or D are clamped by internal diodes. Current should be limited to the maximum ratings given.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Only one absolute maximum rating may be applied at any one time.

Table 5. ADG811/ADG812 Truth Table

ADG811 IN	ADG812 IN	Switch Condition
0	1	On
1	0	Off

Table 6. ADG813 Truth Table

Logic	Switch 1, Switch 4	Switch 2, Switch 3
0	Off	On
1	On	Off

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS

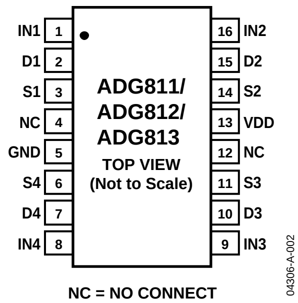


Figure 2. ADG811/ADG812/ADG813 Pin Configuration (16-Lead TSSOP)

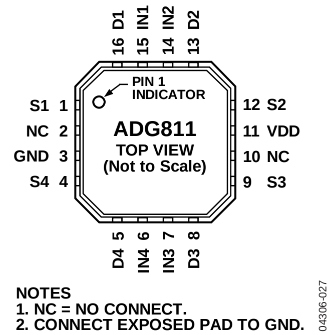


Figure 3. ADG811 Pin Configuration (16-Lead LFCSP)

Table 7. ADG811/ADG812/ADG813 Pin Configuration (16-Lead TSSOP)

Pin No.	Mnemonic	Definition
1	IN1	Logic control input.
2	D1	Drain Terminal. This pin may be an input or output.
3	S1	Source Terminal. This pin may be an input or output.
4	NC	No Connect.
5	GND	Ground (0 V) reference.
6	S4	Source Terminal. This pin may be an input or output.
7	D4	Drain Terminal. This pin may be an input or output.
8	IN4	Logic Control Input.
9	IN3	Logic Control Input.
10	D3	Drain Terminal. This pin may be an input or output.
11	S3	Source Terminal. This pin may be an input or output.
12	NC	No Connect.
13	VDD	Most Positive Power Supply Potential.
14	S2	Source Terminal. This pin may be an input or output.
15	D2	Drain Terminal. This pin may be an input or output.
16	IN2	Logic Control Input.

Table 8. ADG811 Pin Configuration (16-Lead LFCSP)

Pin No.	Mnemonic	Definition
1	S1	Source Terminal. This pin may be an input or output.
2	NC	No Connect.
3	GND	Ground (0 V) Reference.
4	S4	Source Terminal. This pin may be an input or output.
5	D4	Drain Terminal. This pin may be an input or output.
6	IN4	Logic Control Input.
7	IN3	Logic Control Input.
8	D3	Drain Terminal. This pin may be an input or output.
9	S3	Source Terminal. This pin may be an input or output.
10	NC	No Connect.
11	VDD	Most Positive Power Supply Potential.
12	S2	Source Terminal. This pin may be an input or output.
13	D2	Drain Terminal. This pin may be an input or output.
14	IN2	Logic Control Input.
15	IN1	Logic Control Input.
16	D1	Drain Terminal. This pin may be an input or output.
	EPAD	Connect exposed pad to GND.

TYPICAL PERFORMANCE CHARACTERISTICS

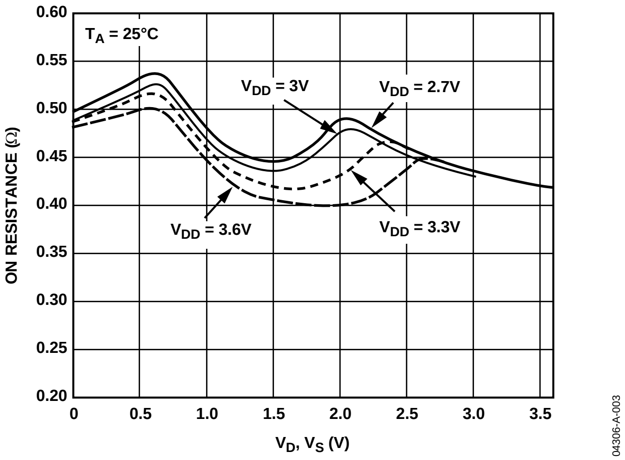


Figure 4. On Resistance vs. V_D (V_S), V_{DD} = 2.7 V to 3.6 V

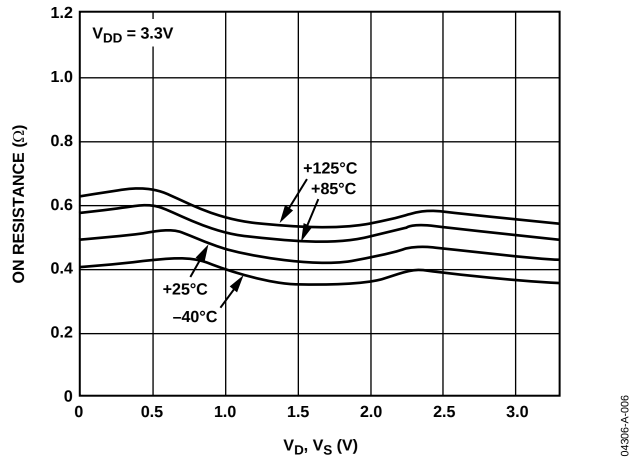


Figure 7. On Resistance vs. V_D (V_S) for Different Temperatures, V_{DD} = 3.3 V

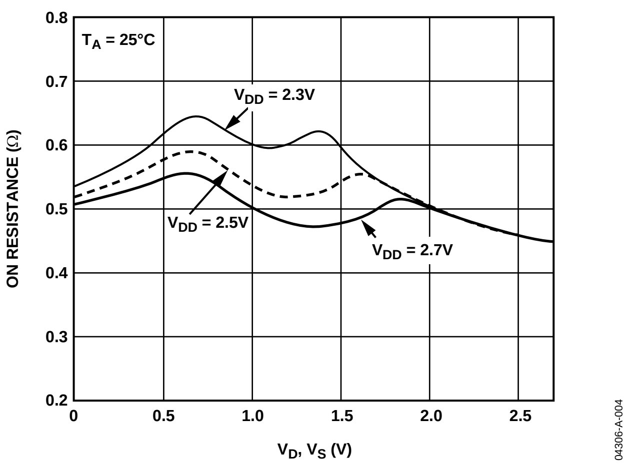


Figure 5. On Resistance vs. V_D (V_S), V_{DD} = 2.5 V ± 0.2 V

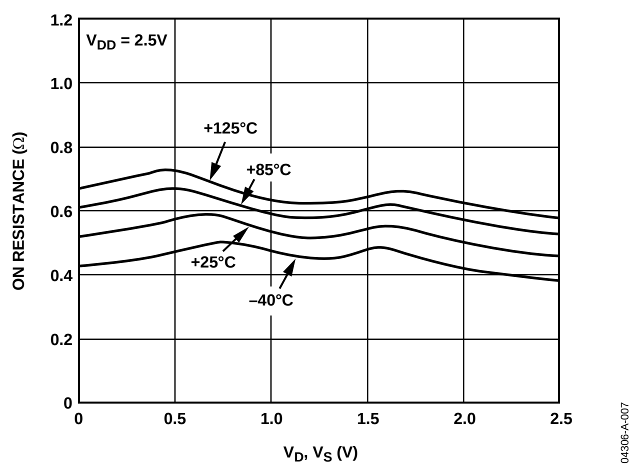


Figure 8. On Resistance vs. V_D (V_S) for Different Temperatures, V_{DD} = 2.5 V

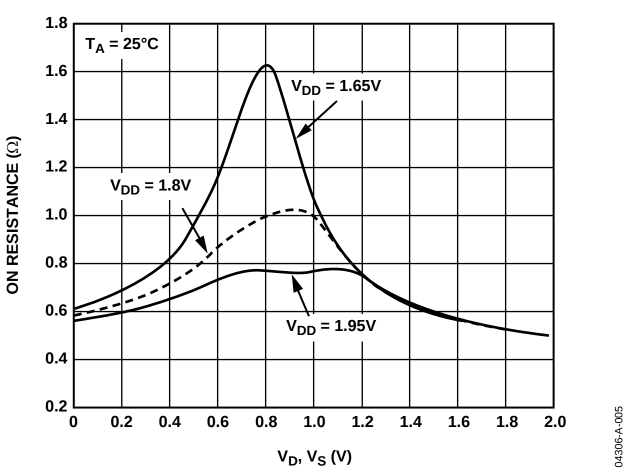


Figure 6. On Resistance vs. V_D (V_S), V_{DD} = 1.8 V ± 0.15 V

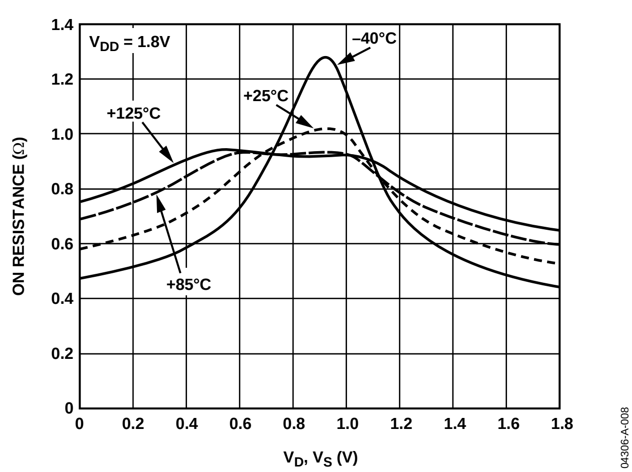


Figure 9. On Resistance vs. V_D (V_S) for Different Temperatures, V_{DD} = 1.8 V

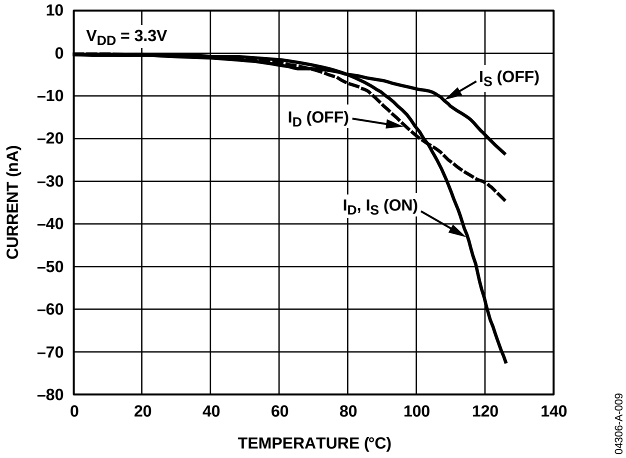


Figure 10. Leakage Current vs. Temperature, V_{DD} = 3.3 V

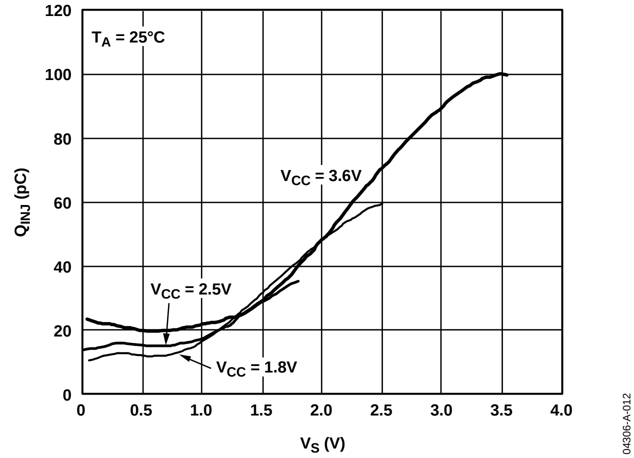


Figure 13. Charge Injection (Q_{INJ}) vs. Source Voltage (V_S)

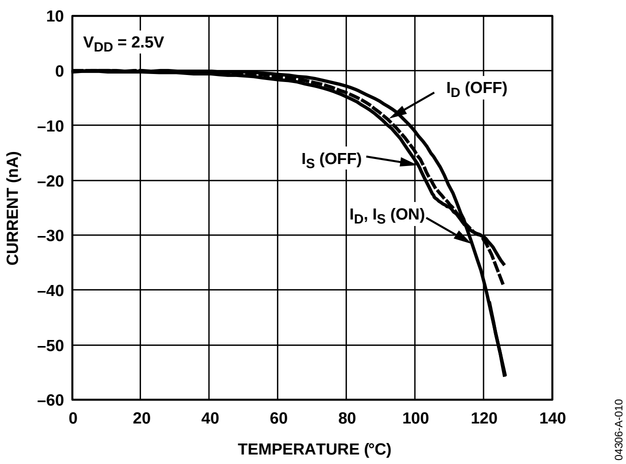


Figure 11. Leakage Current vs. Temperature, V_{DD} = 2.5 V

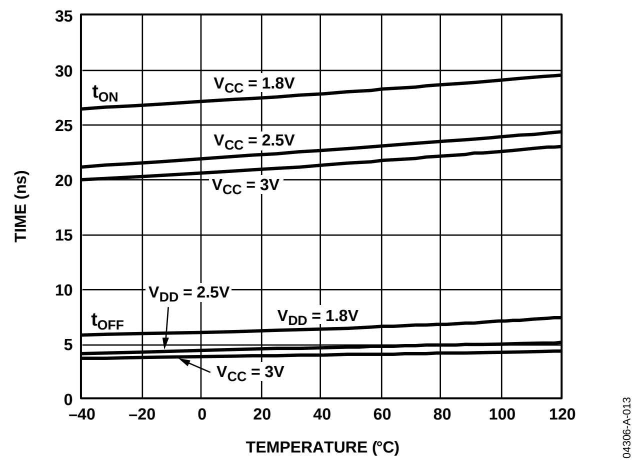


Figure 14. t_{ON}/t_{OFF} Times vs. Temperature

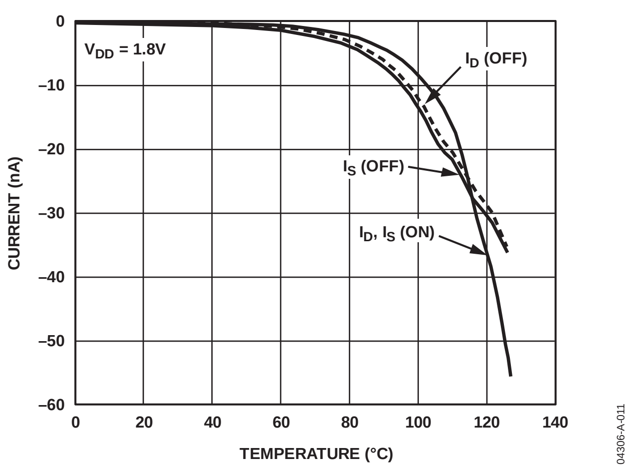


Figure 12. Leakage Current vs. Temperature, V_{DD} = 1.8 V

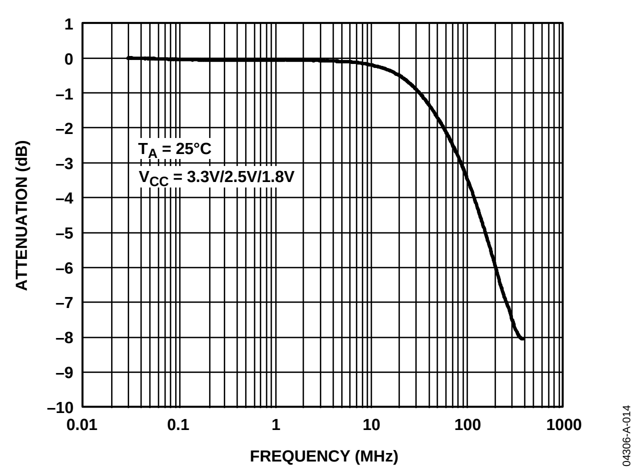


Figure 15. On Response vs. Frequency

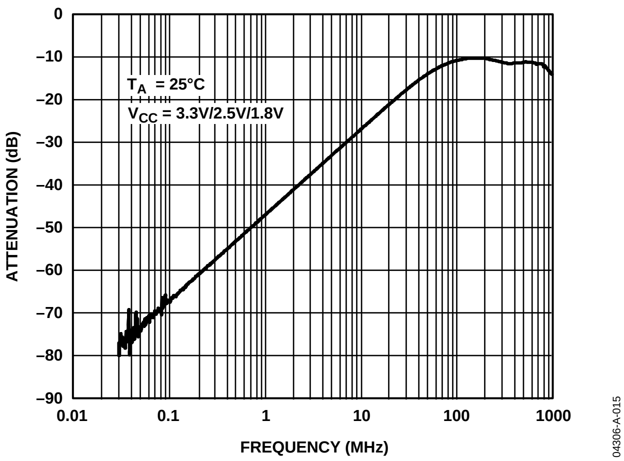


Figure 16. Crosstalk vs. Frequency

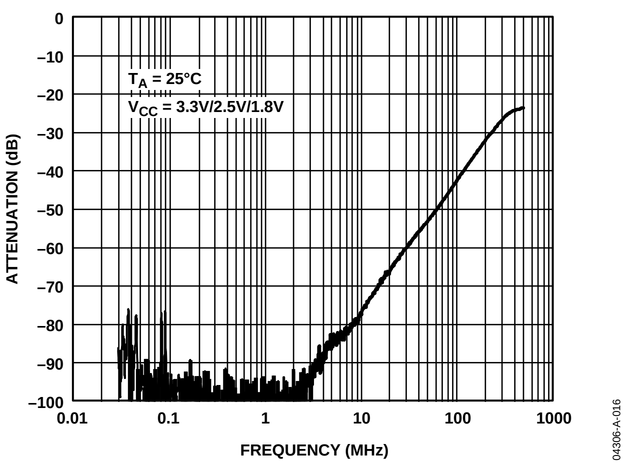


Figure 17. Off Isolation vs. Frequency

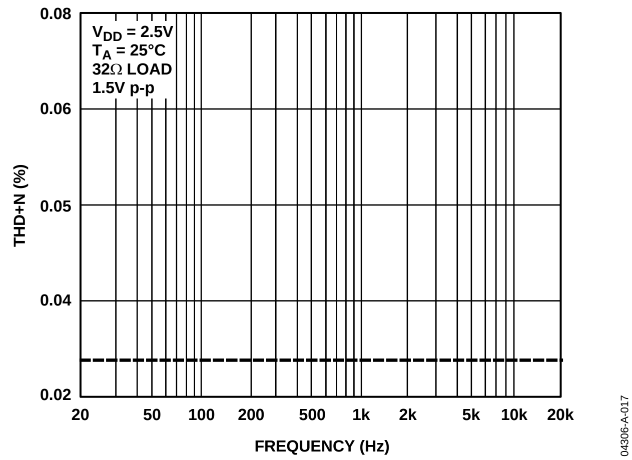


Figure 18. Total Harmonic Distortion + Noise (THD + N) vs. Frequency

TEST CIRCUITS

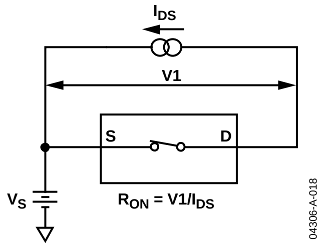


Figure 19. On Resistance

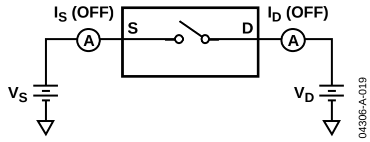


Figure 20. Off Leakage

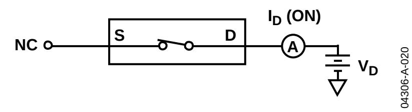


Figure 21. On Leakage

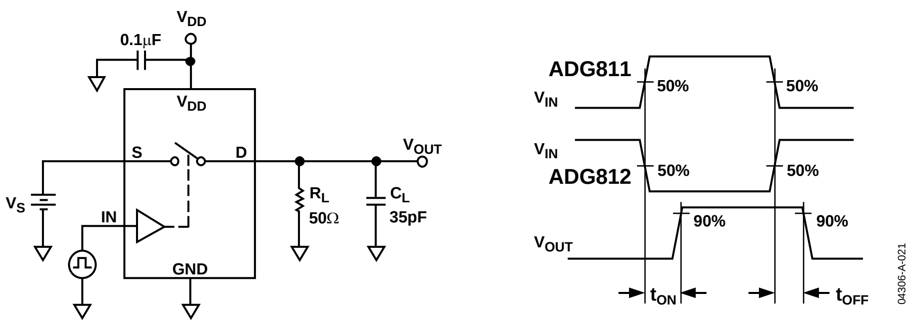


Figure 22. Switching Times

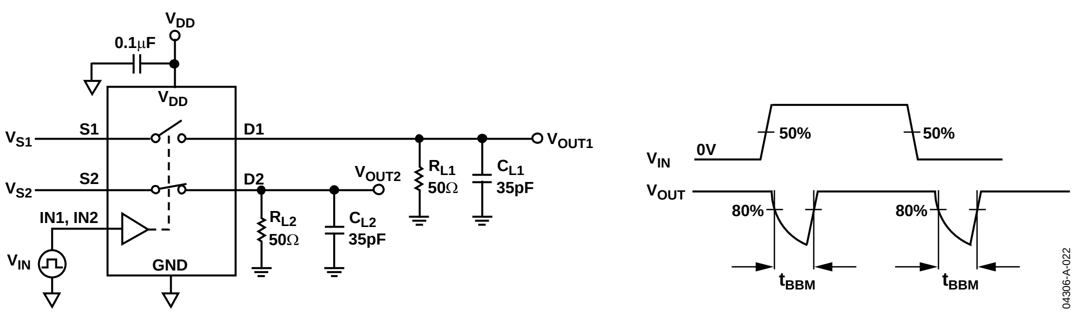


Figure 23. Break-Before-Make Time Delay, t_{BBM} (ADG813 Only)

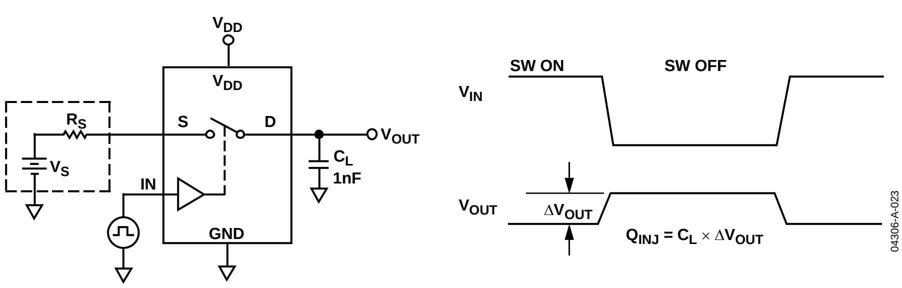


Figure 24. Charge Injection

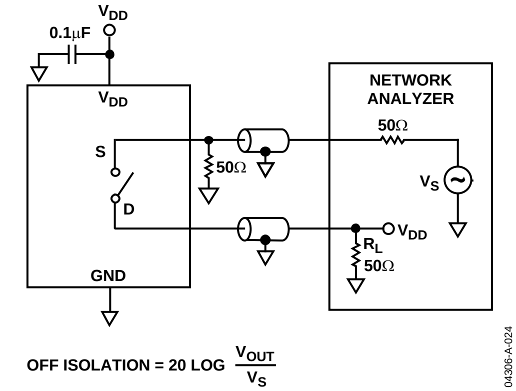


Figure 25. Off Isolation

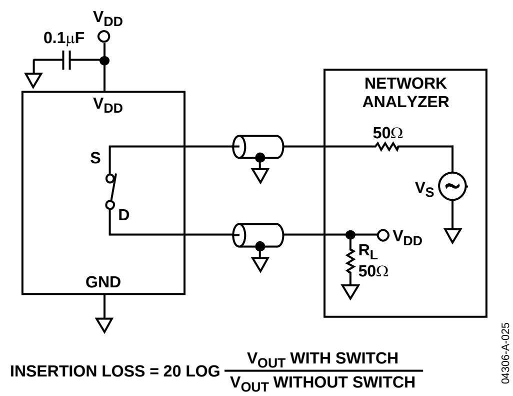


Figure 26. Bandwidth

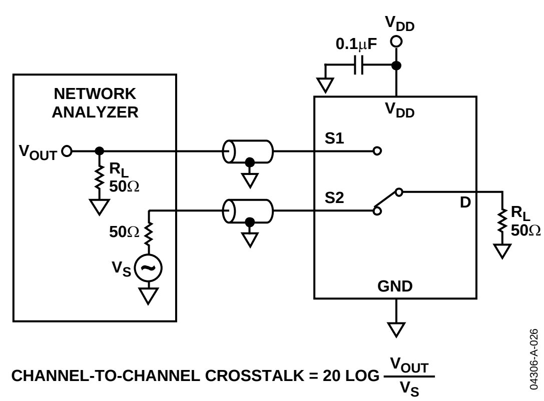


Figure 27. Channel-to-Channel Crosstalk

TERMINOLOGY

I_{DD}
Positive supply current.

V_D, V_S
Analog voltage on Terminal D, Terminal S.

R_{ON}
Ohmic resistance between D and S.

$R_{FLAT (ON)}$
Flatness is defined as the difference between the maximum and minimum value of on resistance as measured over the specified analog signal range.

ΔR_{ON}
On resistance match between any two channels, that is, R_{ON} maximum – R_{ON} minimum.

I_S (Off)
Source leakage current with the switch off.

I_D (Off)
Drain leakage current with the switch off.

I_D, I_S (On)
Channel leakage current with the switch on.

V_{INL}
Maximum input voltage for Logic 0.

V_{INH}
Minimum input voltage for Logic 1.

I_{INL} (I_{INH})
Input current of the digital input.

C_S (Off)
Off switch source capacitance. Measured with reference to ground.

C_D (Off)
Off switch drain capacitance. Measured with reference to ground.

C_D, C_S (On)
On switch capacitance. Measured with reference to ground.

C_{IN}
Digital input capacitance.

t_{ON}
Delay time between the 50% and the 90% points of the digital input and switch on condition.

t_{OFF}
Delay time between the 50% and the 90% points of the digital input and switch off condition.

t_{BBM}
On or off time measured between the 80% points of both switches, when switching from one to another.

Charge Injection
A measure of the glitch impulse transferred from the digital input to the analog output during on-to-off switching.

Off Isolation
A measure of unwanted signal coupling through an off switch.

Crosstalk
A measure of unwanted signal that is coupled through from one channel to another because of parasitic capacitance.

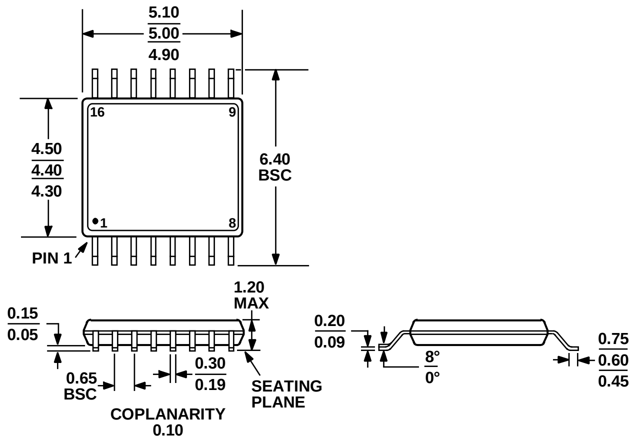
–3 dB Bandwidth
The frequency at which the output is attenuated by 3 dB.

On Response
The frequency response of the on switch.

Insertion Loss
The loss due to the on resistance of the switch.

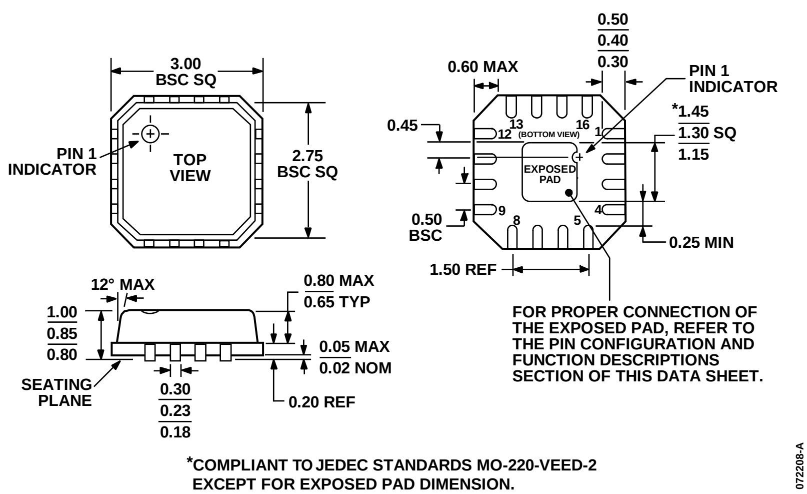
THD + N
The ratio of the harmonic amplitudes plus noise of a signal to the fundamental.

OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-153-AB

Figure 28. 16-Lead Thin Shrink Small Outline Package [TSSOP]
(RU-16)
Dimensions shown in millimeters



*COMPLIANT TO JEDEC STANDARDS MO-220-VEED-2
EXCEPT FOR EXPOSED PAD DIMENSION.

Figure 29. 16-Lead Lead Frame Chip Scale Package [LFCSP_VQ]
3 mm × 3 mm Body, Very Thin Quad
(CP-16-2)
Dimensions shown in millimeters

ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option
ADG811YRU	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16
ADG811YRU-REEL	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16
ADG811YRU-REEL7	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16
ADG811YRUZ[1]	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16
ADG811YCPZ-REEL[1]	–40°C to +125°C	16-Lead Lead Frame Chip Scale Package [LFCSP_VQ]	CP-16-2
ADG811YCPZ-REEL7[1]	–40°C to +125°C	16-Lead Lead Frame Chip Scale Package [LFCSP_VQ]	CP-16-2
ADG812YRU	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16
ADG812YRU-REEL	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16
ADG812YRU-REEL7	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16
ADG812YRUZ[1]	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16
ADG812YRUZ-REEL7[1]	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16
ADG813YRU	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16
ADG813YRU-REEL	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16
ADG813YRU-REEL7	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16
ADG813YRUZ[1]	–40°C to +125°C	16-Lead Thin Shrink Small Outline [TSSOP]	RU-16

[1] Z = RoHS Compliant Part.

NOTES

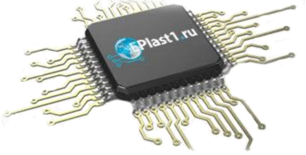
Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits,General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

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